## Application/Control No. Applicant(s)/Patent Under Reexamination 09/874,283 KUDO ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 VAN H. NGUYEN 2194

## **U.S. PATENT DOCUMENTS**

*	_	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,738,975	05-2004	Yee et al.	719/310
*	В	US-6,256,676	07-2001	Taylor et al.	709/246
*	С	US-4,714,995	12-1987	Materna et al.	707/201
·	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	s					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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